Document Number: MRFE6S9135H
Rev. 1, 11/2007

RoHS

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

MRFE6S9135HR3
MRFE6S9135HSR3

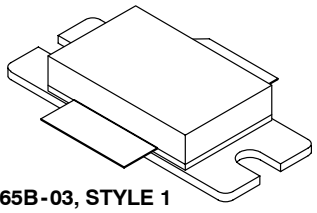
940 MHz, 39 W AVG., 28 V
SINGLE W-CDMA
LATERAL N-CHANNEL
RF POWER MOSFETs

Designed for broadband commercial and industrial applications with frequencies up to 1000 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 28 volt base station equipment.

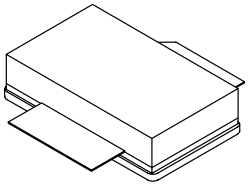
- Typical Single-Carrier W-CDMA Performance: V_{DD} = 28 Volts, I_{DQ} = 1000 mA, P_{out} = 39 Watts Avg., Full Frequency Band, 3GPP Test Model 1, 64 DPCH with 50% Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.
  Power Gain — 21 dB
  Drain Efficiency — 32.3%
  Device Output Signal PAR — 6.4 dB @ 0.01% Probability on CCDF
  ACPR @ 5 MHz Offset — -39.5 dBc in 3.84 MHz Channel Bandwidth
- Capable of Handling 10:1 VSWR, @ 32 Vdc, 940 MHz, P_{out} = 180 W CW (3 dB Input Overdrive from Rated P_{out}), Designed for Enhanced Ruggedness

Features

- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32 V_{DD} Operation
- Integrated ESD Protection
- Optimized for Doherty Applications
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.



CASE 465B-03, STYLE 1
NI-880
MRFE6S9135HR3



CASE 465C-02, STYLE 1
NI-880S
MRFE6S9135HSR3

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +66	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +12	Vdc
Storage Temperature Range	T_{stg}	- 65 to +150	°C
Case Operating Temperature	T_C	150	°C
Operating Junction Temperature (1,2)	T_J	225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 80°C, 136 W CW Case Temperature 80°C, 39 W CW	$R_{\theta JC}$	 0.39 0.48	°C/W

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1955.

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Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	II (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

Table 4. Electrical Characteristics (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current (V_{DS} = 66 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 28 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current (V_{GS} = 5 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	—	—	10	μAdc
On Characteristics					
Gate Threshold Voltage (V_{DS} = 10 Vdc, I_D = 400 μAdc)	$V_{GS(th)}$	1.4	2.1	2.9	Vdc
Gate Quiescent Voltage (V_{DD} = 28 Vdc, I_D = 1000 mAdc, Measured in Functional Test)	$V_{GS(Q)}$	2.2	2.9	3.7	Vdc
Drain-Source On-Voltage (V_{GS} = 10 Vdc, I_D = 2.8 Adc)	$V_{DS(on)}$	0.15	0.2	0.35	Vdc
Dynamic Characteristics (1)					
Reverse Transfer Capacitance (V_{DS} = 28 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{rss}	—	1.3	—	pF
Output Capacitance (V_{DS} = 28 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{oss}	—	410	—	pF
Input Capacitance (V_{DS} = 28 Vdc, V_{GS} = 0 Vdc ± 30 mV(rms)ac @ 1 MHz)	C_{iss}	—	343	—	pF

Functional Tests (In Freescale Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQ} = 1000 mA, P_{out} = 39 W Avg. W-CDMA, f = 940 MHz, Single-Carrier W-CDMA, 3.84 MHz Channel Bandwidth Carrier. ACPR measured in 3.84 MHz Channel Bandwidth @ ±5 MHz Offset. PAR = 7.5 dB @ 0.01% Probability on CCDF.

Power Gain	G_{ps}	20	21	23	dB
Drain Efficiency	η_D	30.5	32.3	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	6.1	6.4	—	dB
Adjacent Channel Power Ratio	ACPR	—	-39.5	-38	dBc
Input Return Loss	IRL	—	-15	-9	dB

1. Part internally matched both on input and output.

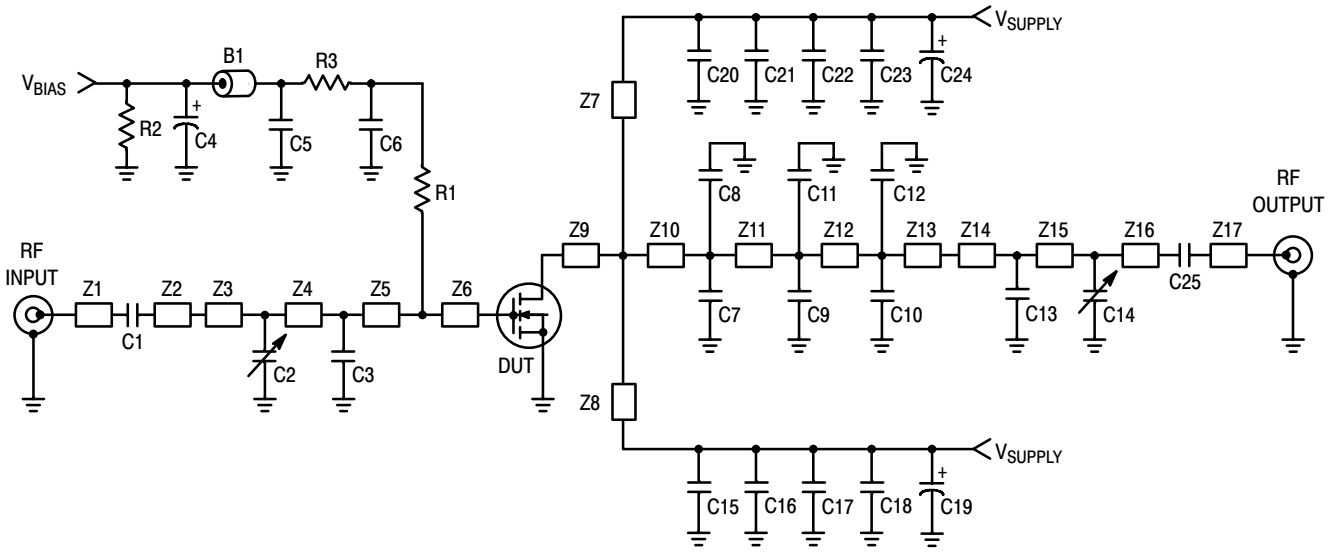
(continued)

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Table 4. Electrical Characteristics (T_C = 25°C unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
Typical Performances (In Freescale Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQ} = 1000 mA, 920-960 MHz Bandwidth					
Video Bandwidth @ 160 W PEP P_{out} where IM3 = -30 dBc (Tone Spacing from 100 kHz to VBW) ΔIMD3 = IMD3 @ VBW frequency - IMD3 @ 100 kHz <1 dBc (both sidebands)	VBW	—	10	—	MHz
Gain Flatness in 40 MHz Bandwidth @ P_{out} = 39 W Avg.	G_F	—	0.3	—	dB
Average Deviation from Linear Phase in 40 MHz Bandwidth @ P_{out} = 135 W CW	Φ	—	1	—	°
Average Group Delay @ P_{out} = 135 W CW, f = 940 MHz	Delay	—	3.6	—	ns
Part-to-Part Insertion Phase Variation @ P_{out} = 135 W CW, f = 940 MHz, Six Sigma Window	ΔΦ	—	19	—	°
Gain Variation over Temperature (-30°C to +85°C)	ΔG	—	0.015	—	dB/°C
Output Power Variation over Temperature (-30°C to +85°C)	ΔP1dB	—	0.01	—	dBm/°C

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Z1	0.263″ x 0.065″ Microstrip	Z11	0.202″ x 0.980″ x 0.444″ Taper
Z2	0.310″ x 0.065″ Microstrip	Z12	0.114″ x 0.444″ Microstrip
Z3	0.910″ x 0.120″ Microstrip	Z13	0.145″ x 0.444″ x 0.110″ Taper
Z4	0.248″ x 1.020″ x 0.120″ Taper	Z14	0.180″ x 0.110″ Microstrip
Z5	0.363″ x 1.020″ Microstrip	Z15	0.585″ x 0.110″ Microstrip
Z6	0.057″ x 1.120″ Microstrip	Z16	0.443″ x 0.065″ Microstrip
Z7, Z8	0.823″ x 0.120″ Microstrip	Z17	0.274″ x 0.065″ Microstrip
Z9	0.060″ x 0.980″ Microstrip	PCB	Taconic RF-35, 0.030″, ε_r = 3.5
Z10	0.149″ x 0.980″ Microstrip		

Figure 1. MRFE6S9135HR3(HSR3) Test Circuit Schematic

Table 5. MRFE6S9135HR3(HSR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1	Short RF Bead	2743019447	Fair-Rite
C1, C6, C15, C20, C25	39 pF Chip Capacitors	ATC100B390JT500XT	ATC
C2, C14	0.8-8.0 pF Variable Capacitors, Gigatrim	27291SL	Johanson
C3	2.0 pF Chip Capacitor	ATC100B2R0JT500XT	ATC
C4	33 µF, 25 V Electrolytic Capacitor	EMVY250ADA330MF55G	Nippon Chemi-Con
C5, C16, C17, C18, C21, C22, C23	10 µF, 50 V Chip Capacitors	GRM55DR61H106KA88B	Murata
C7, C8	6.8 pF Chip Capacitors	ATC100B6R8JT500XT	ATC
C9, C10, C11, C12, C13	4.7 pF Chip Capacitors	ATC100B4R7JT500XT	ATC
C19, C24	470 µF, 63 V Electrolytic Capacitors	EKME630ELL471MK25S	United Chemi-Con
R1, R3	3.3 Ω, 1/3 W Chip Resistors	CRCW12103R30FKEA	Vishay
R2	2.2 KΩ, 1/4 W Chip Resistor	CRCW12062201FKEA	Vishay

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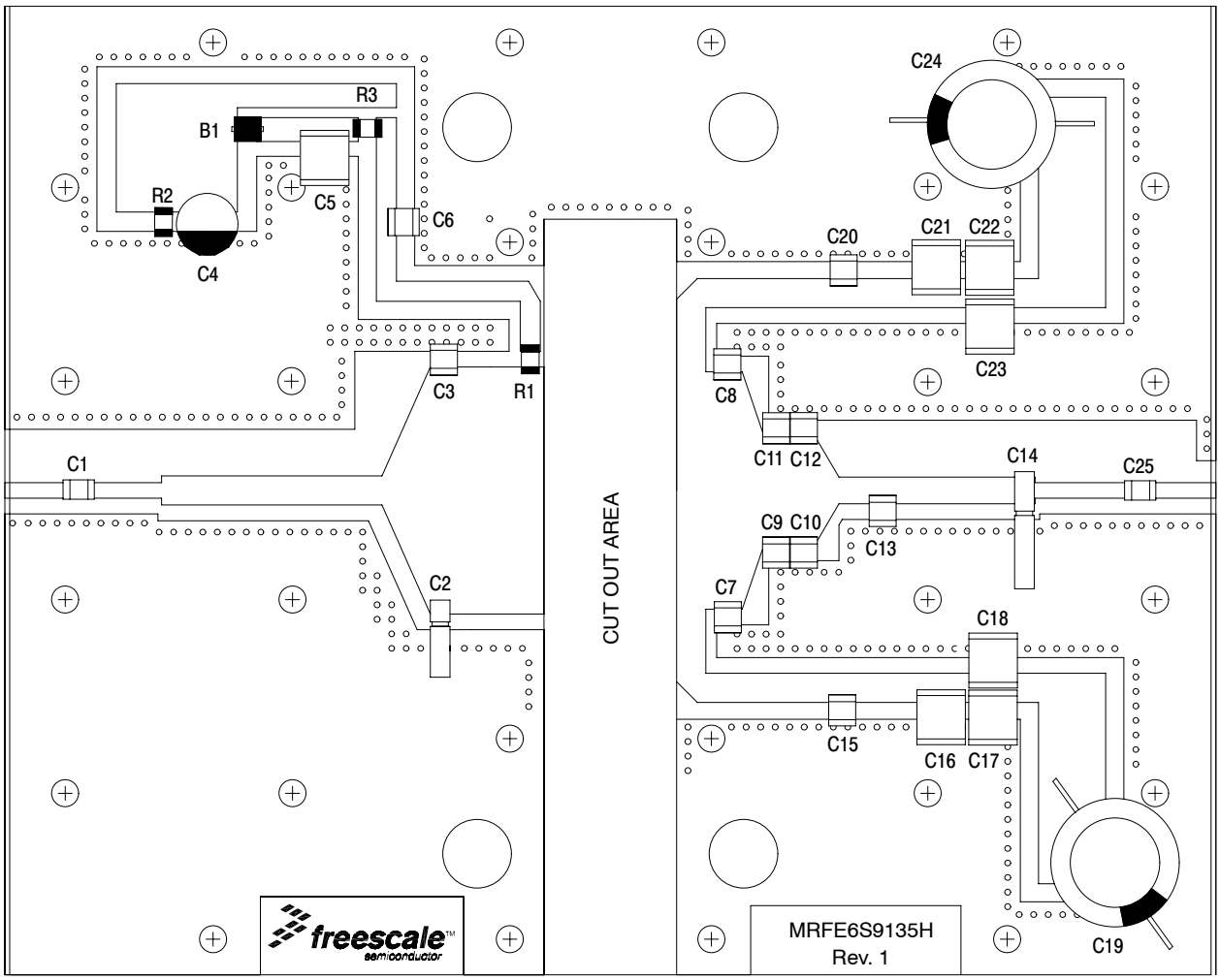


Figure 2. MRFE6S9135HHR3(HSR3) Test Circuit Component Layout

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TYPICAL CHARACTERISTICS

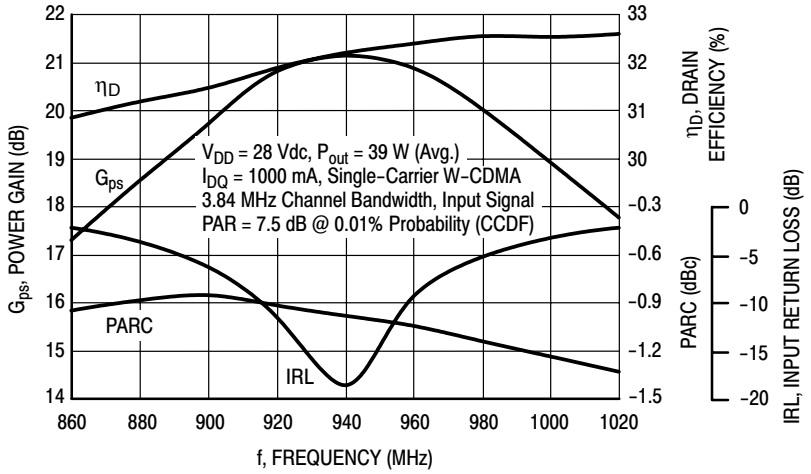


Figure 3. Single-Carrier W-CDMA Broadband Performance @ P_{out} = 39 Watts Avg.

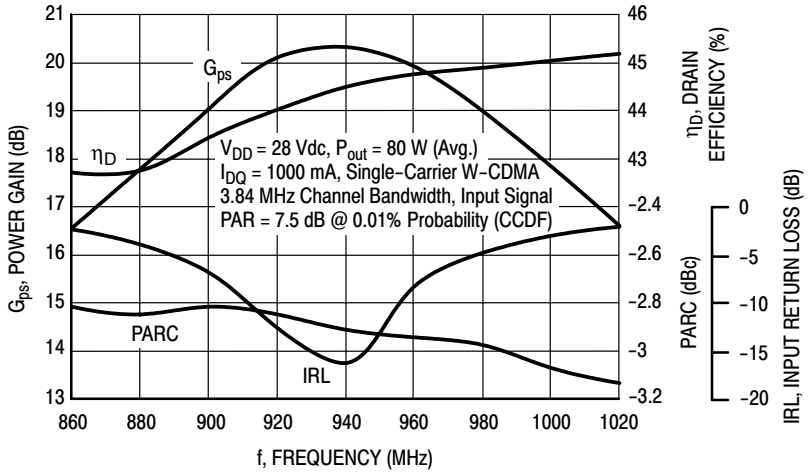


Figure 4. Single-Carrier W-CDMA Broadband Performance @ P_{out} = 80 Watts Avg.

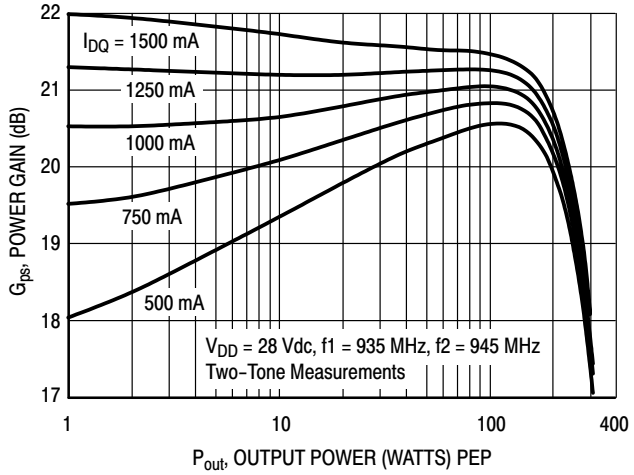


Figure 5. Two-Tone Power Gain versus Output Power

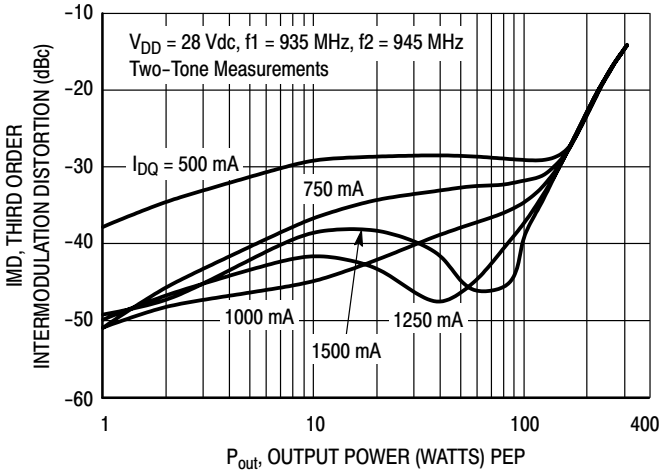


Figure 6. Third Order Intermodulation Distortion versus Output Power

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TYPICAL CHARACTERISTICS

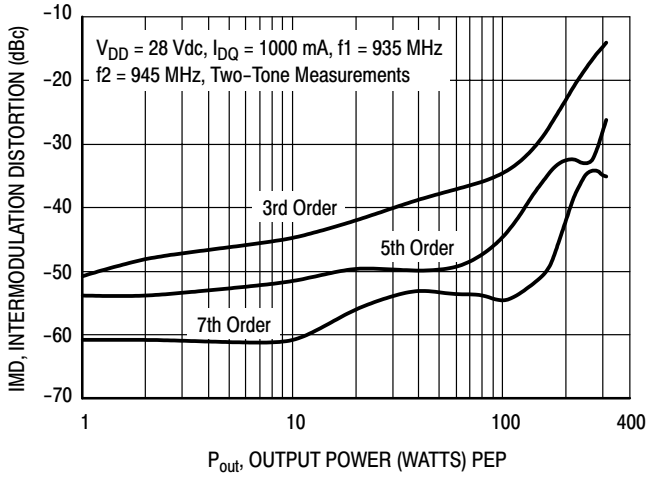


Figure 7. Intermodulation Distortion Products versus Output Power

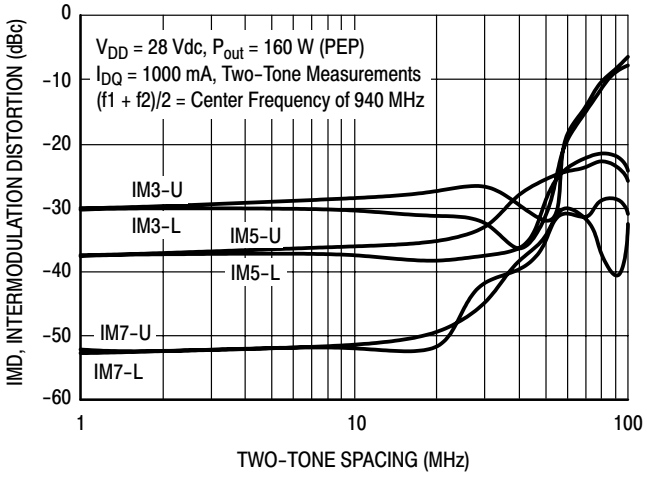


Figure 8. Intermodulation Distortion Products versus Tone Spacing

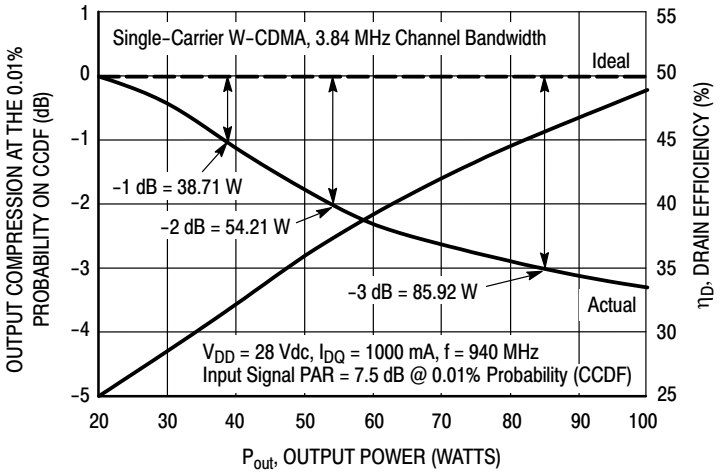


Figure 9. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

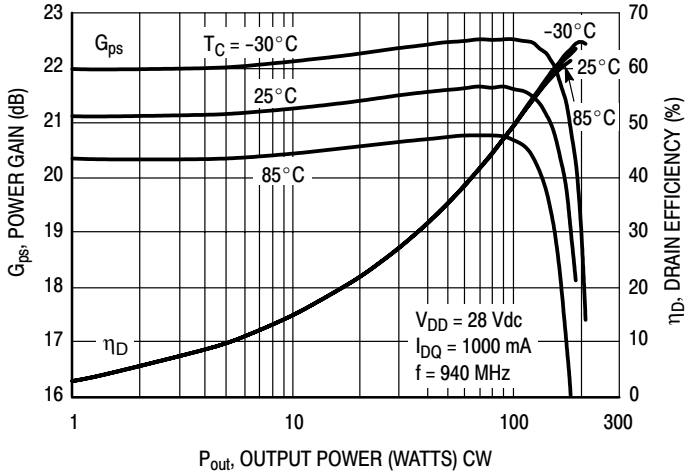


Figure 10. Power Gain and Drain Efficiency versus CW Output Power

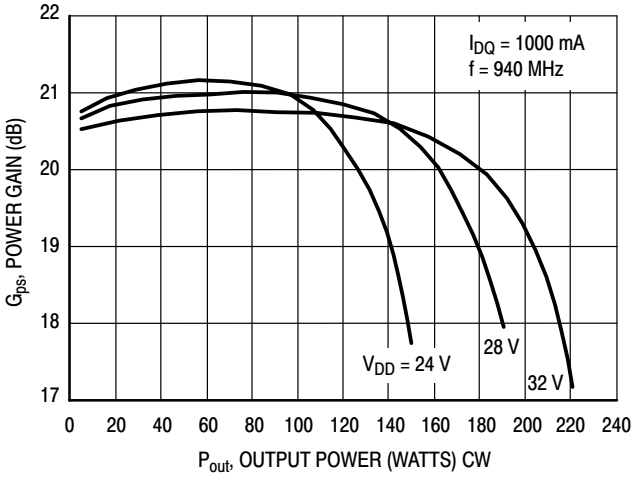
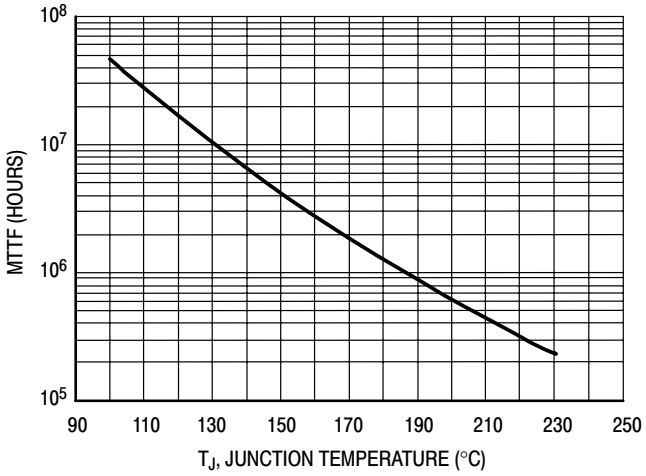


Figure 11. Power Gain versus Output Power

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TYPICAL CHARACTERISTICS



This above graph displays calculated MTTF in hours when the device is operated at V_{DD} = 28 Vdc, P_{out} = 39 W Avg., and η_D = 32.3%.

MTTF calculator available at http:/www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Figure 12. MTTF versus Junction Temperature

W-CDMA TEST SIGNAL

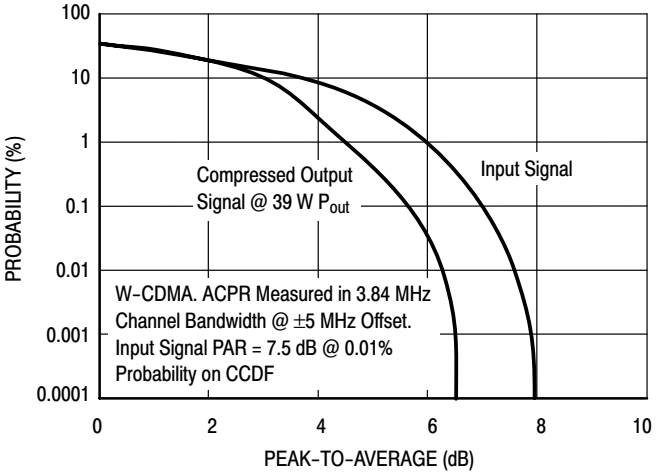


Figure 13. CCDF W-CDMA 3GPP, Test Model 1, 64 DPCH, 50% Clipping, Single-Carrier Test Signal

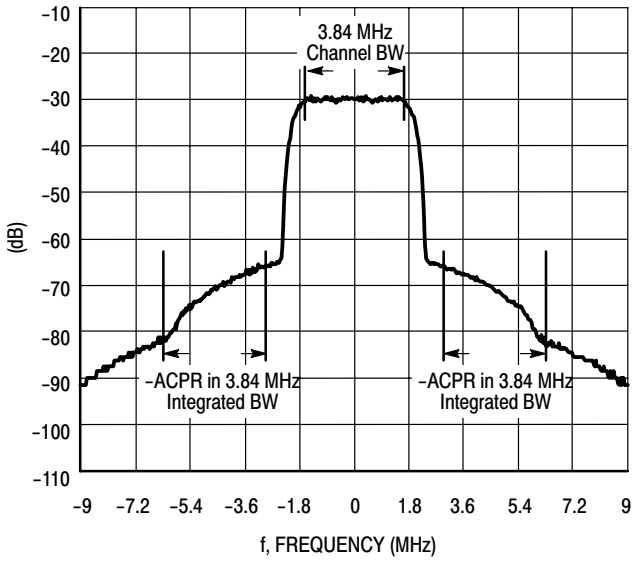
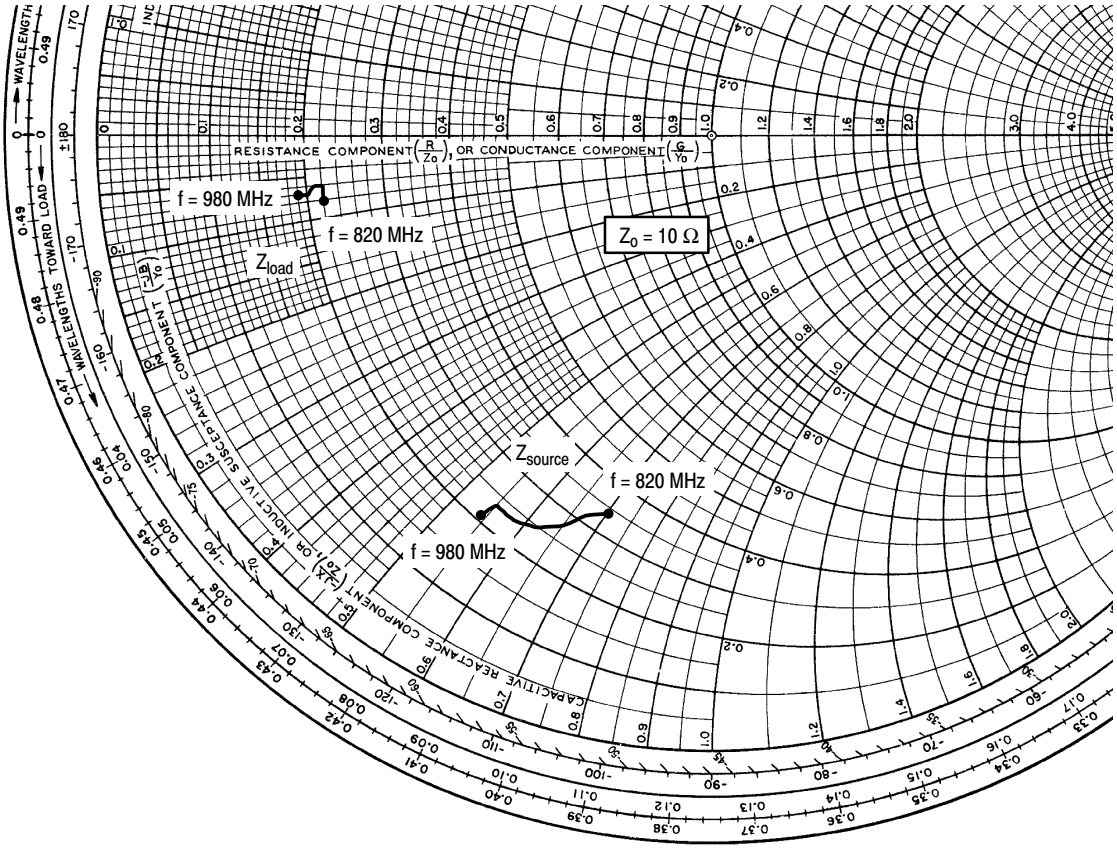


Figure 14. Single-Carrier W-CDMA Spectrum

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V_{DD} = 28 Vdc, I_{DQ} = 1000 mA, P_{out} = 39 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
820	3.39 - j6.99	2.18 - j0.80
840	3.32 - j6.86	2.20 - j0.71
860	3.05 - j6.74	2.21 - j0.66
880	2.72 - j6.47	2.20 - j0.64
900	2.46 - j6.16	2.20 - j0.64
920	2.41 - j5.80	2.18 - j0.62
940	2.41 - j5.58	2.13 - j0.63
960	2.38 - j5.45	2.03 - j0.66
980	2.13 - j5.38	1.87 - j0.70

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

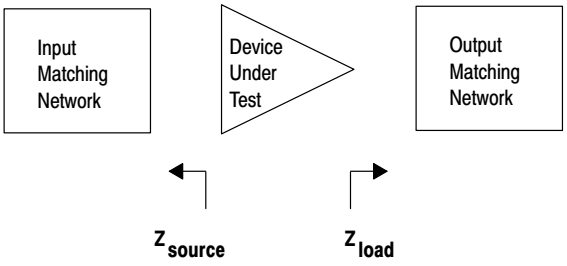
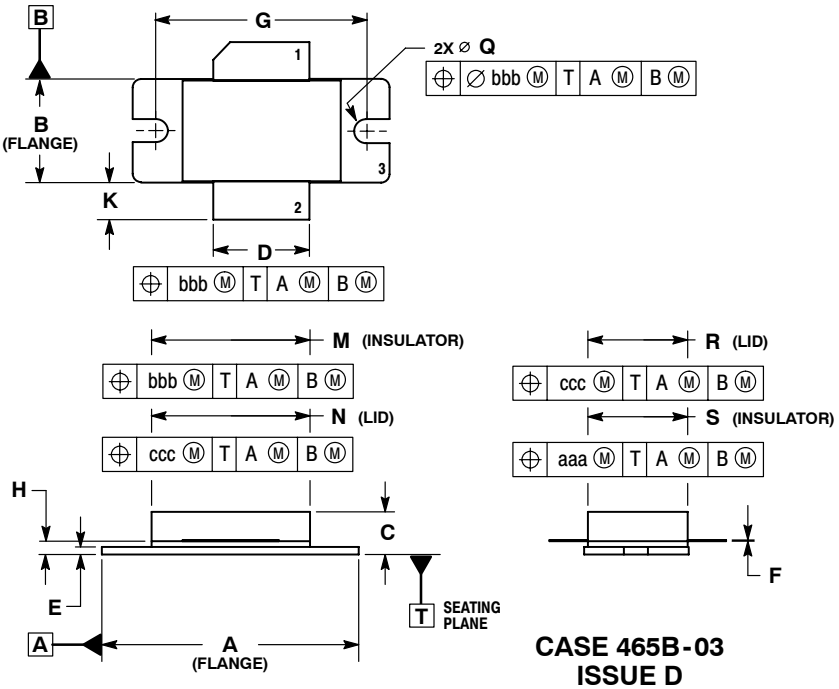


Figure 15. Series Equivalent Source and Load Impedance

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PACKAGE DIMENSIONS

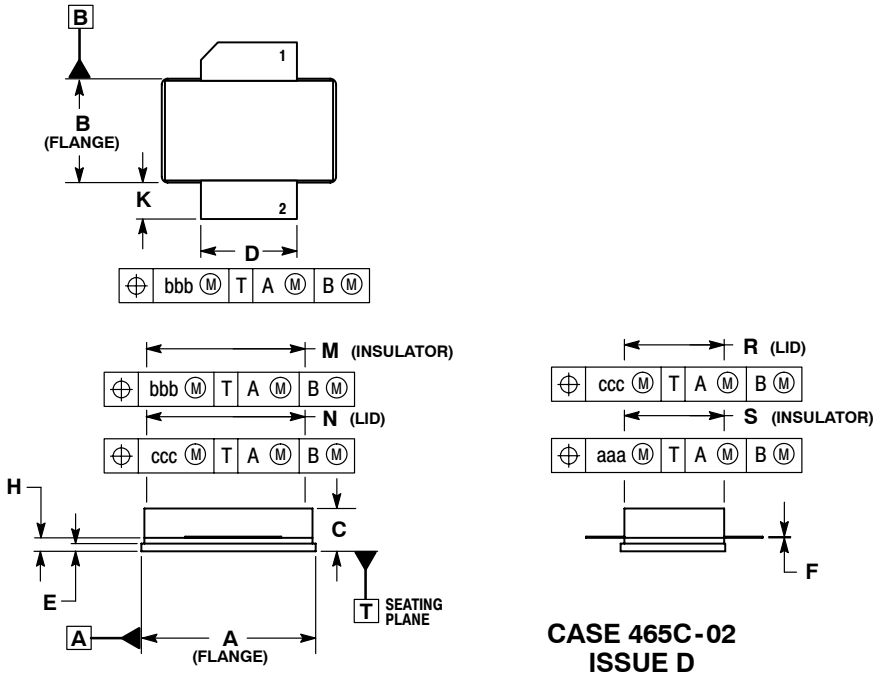


NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M–1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.
4. DELETED

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16
B	0.535	0.545	13.6	13.8
C	0.147	0.200	3.73	5.08
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
G	1.100 BSC		27.94 BSC	
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.872	0.888	22.15	22.55
N	0.871	0.889	19.30	22.60
Q	Ø.118	Ø.138	Ø3.00	Ø3.51
R	0.515	0.525	13.10	13.30
S	0.515	0.525	13.10	13.30
aaa	0.007 REF		0.178 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

STYLE 1:
PIN 1. DRAIN
2. GATE
3. SOURCE

CASE 465B-03
ISSUE D
NI-880
MRFE6S9135HR3



NOTES:
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3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	0.905	0.915	22.99	23.24
B	0.535	0.545	13.60	13.80
C	0.147	0.200	3.73	5.08
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.872	0.888	22.15	22.55
N	0.871	0.889	19.30	22.60
R	0.515	0.525	13.10	13.30
S	0.515	0.525	13.10	13.30
aaa	0.007 REF		0.178 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

STYLE 1:
PIN 1. DRAIN
2. GATE
3. SOURCE

CASE 465C-02
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PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Nov. 2007	• Initial Release of Data Sheet
1	Nov. 2007	• Updated Fig. 12, MTTF versus Junction Temperature, to reflect a 32.3% typical efficiency rating, p. 8

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